

FORM PTO-1449

U.S. Department of Commerce
Patent and Trademark OfficeAtty. Doct. No.
P21060Application No.
09/995,696INFORMATION DISCLOSURE STATEMENT
BY APPLICANT
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Takefumi WAKABAYASHIFiling Date
November 29, 2001Group
2157

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
S. N.	2000 - 2 2 2 3 3 3	08/11/00	JAPAN			
S. N.	10 - 2 6 9 0 3 9	10/09/98	JAPAN			
S. N.	11 - 0 0 8 7 2 7	01/12/99	JAPAN			
S. N.	2002 - 1 1 1 9 4 6	04/12/02	JAPAN			
S. N.	2001 - 0 5 6 7 8 9	02/27/01	JAPAN			
S. N.	2000 - 3 1 1 0 9 5	11/07/00	JAPAN			
S. N.	2 - 1 7 2 3 4 8	07/03/90	JAPAN			
S. N.	6 - 2 7 6 3 1 3	09/30/94	JAPAN			
S. N.	11 - 2 3 4 4 5 4	08/27/99	JAPAN			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

S. N.	1	English Language Abstract of JP 2000-222333.
S. N.	2	English Language Abstract of JP 10-269039.
S. N.	3	English Language Abstract of JP 11-008727.
S. N.	4	English Language Abstract of JP 2002-111946.
S. N.	5	English Language Abstract of JP 2001-056789.
S. N.	6	English Language Abstract of JP 2000-311095.
S. N.	7	English Language Abstract of JP 2-172348.
S. N.	8	English Language Abstract of JP 6-276313.
S. N.	9	English Language Abstract of JP 11-234454.

EXAMINER SARGON NANO

DATE CONSIDERED 7-7-06

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